

# MCP1827/MCP1827S

## 1.5A, Low Voltage, Low Quiescent Current LDO Regulator

#### **Features**

- · 1.5A Output Current Capability
- Input Operating Voltage Range: 2.3V to 6.0V
- Adjustable Output Voltage Range: 0.8V to 5.0V (MCP1827 only)
- · Standard Fixed Output Voltages:
  - 0.8V, 1.2V, 1.8V, 2.5V, 3.0V, 3.3V, 5.0V
- Other Fixed Output Voltage Options Available Upon Request
- · Low Dropout Voltage: 330 mV Typical at 1.5A
- · Typical Output Voltage Tolerance: 0.5%
- Stable with 1.0 µF Ceramic Output Capacitor
- · Fast response to Load Transients
- Low Supply Current: 120 μA (typ)
- Low Shutdown Supply Current: 0.1 μA (typ) (MCP1827 only)
- Fixed Delay on Power Good Output (MCP1827 only)
- Short Circuit Current Limiting and Overtemperature Protection
- 5-Lead Plastic DDPAK, 5-Lead TO-220 Package Options (MCP1827)
- 3-Lead Plastic DDPAK, 3-Lead TO-220 Package Options (MCP1827S)

#### **Applications**

- · High-Speed Driver Chipset Power
- Networking Backplane Cards
- · Notebook Computers
- · Network Interface Cards
- · Palmtop Computers
- · 2.5V to 1.XV Regulators

### **Description**

The MCP1827/MCP1827S is a 1.5A Low Dropout (LDO) linear regulator that provides high current and low output voltages. The MCP1827 comes in a fixed or adjustable output voltage version, with an output voltage range of 0.8V to 5.0V. The 1.5A output current capability, combined with the low output voltage capability, make the MCP1827 a good choice for new sub-1.8V output voltage LDO applications that have high current demands. The MCP1827S is a 3-pin fixed voltage version. The MCP1827/MCP1827S is based upon the MCP1727 LDO device.

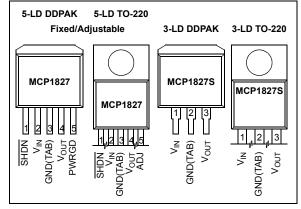
The MCP1827/MCP1827S is stable using ceramic output capacitors that inherently provide lower output noise and reduce the size and cost of the entire regulator solution. Only 1  $\mu F$  of output capacitance is needed to stabilize the LDO.

Using CMOS construction, the quiescent current consumed by the MCP1827/MCP1827S is typically less than 120  $\mu A$  over the entire input voltage range, making it attractive for portable computing applications that demand high output <u>current</u>. The MCP1827 versions have a Shutdown (SHDN) pin. When shut down, the quiescent current is reduced to less than 0.1  $\mu A$ .

On the MCP1827 fixed output versions the scaled-down output voltage is internally monitored and a power good (PWRGD) output is provided when the output is within 92% of regulation (typical). The PWRGD delay is internally fixed at 200 µs (typical).

The overtemperature and short circuit current-limiting provide additional protection for the LDO during system fault conditions.

## Package Types



# 1.0 ELECTRICAL CHARACTERISTICS

## **Absolute Maximum Ratings †**

 † Notice: Stresses above those listed under "Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at those or any other conditions above those indicated in the operational listings of this specification is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

## AC/DC CHARACTERISTICS

**Electrical Specifications:** Unless otherwise noted,  $V_{IN} = V_{OUT(MAX)} + V_{DROPOUT(MAX)}$  **Note 1**,  $V_{R}$ =1.8V for Adjustable Output,  $I_{OUT} = 1$  mA,  $C_{IN} = C_{OUT} = 4.7 \,\mu\text{F}$  (X7R Ceramic),  $T_{A} = +25\,^{\circ}\text{C}$ . **Boldface** type applies for junction temperatures,  $T_{J}$  (**Note 7**) of -40 $^{\circ}\text{C}$  to +125 $^{\circ}\text{C}$ 

Parameters	Sym	Min	Тур	Max	Units	Conditions
Input Operating Voltage	V <sub>IN</sub>	2.3		6.0	V	Note 1
Input Quiescent Current	Iq	_	120	220	μА	I <sub>L</sub> = 0 mA, V <sub>IN</sub> = <b>Note 1</b> , V <sub>OUT</sub> = 0.8V to 5.0V
Input Quiescent Current for SHDN Mode	ISHDN	_	0.1	3	μА	SHDN = GND
Maximum Output Current	I <sub>OUT</sub>	1.5	_	_	А	V <sub>IN</sub> = 2.3V to 6.0V V <sub>R</sub> = 0.8V to 5.0V, <b>Note 1</b>
Line Regulation	$\Delta V_{OUT}/$ $(V_{OUT} \times \Delta V_{IN})$	_	0.05	0.16	%/V	(Note 1) ≤ V <sub>IN</sub> ≤ 6V
Load Regulation	$\Delta V_{OUT}/V_{OUT}$	-1.0	±0.5	1.0	%	I <sub>OUT</sub> = 1 mA to 1.5A, V <sub>IN</sub> = <b>Note 1</b> , ( <b>Note 4</b> )
Output Short Circuit Current	I <sub>OUT_SC</sub>	_	2.2	_	А	$V_{IN}$ = <b>Note 1</b> , $R_{LOAD}$ < 0.1Ω, Peak Current
Adjust Pin Characteristics (Adj	ustable Output Or	nly)	-			
Adjust Pin Reference Voltage	$V_{ADJ}$	0.402	0.410	0.418	V	$V_{IN} = 2.3V \text{ to } V_{IN} = 6.0V,$ $I_{OUT} = 1 \text{ mA}$
Adjust Pin Leakage Current	I <sub>ADJ</sub>	-10	±0.01	+10	nA	V <sub>IN</sub> = 6.0V, V <sub>ADJ</sub> = 0V to 6V
Adjust Temperature Coefficient	TCV <sub>OUT</sub>	_	40	_	ppm/°C	Note 3
Fixed-Output Characteristics (Fixed Output Only)						

- Note 1: The minimum  $V_{IN}$  must meet two conditions:  $V_{IN} \ge 2.3V$  and  $V_{IN} \ge V_{OUT(MAX)} + V_{DROPOUT(MAX)}$ .
  - 2:  $V_R$  is the nominal regulator output voltage for the fixed cases.  $V_R$  = 1.2V, 1.8V, etc.  $V_R$  is the desired set point output voltage for the adjustable cases.  $V_R$  =  $V_{ADJ}$  \* (( $R_1/R_2$ )+1). Figure 4-1.
  - 3: TCV<sub>OUT</sub> = (V<sub>OUT-HIGH</sub> V<sub>OUT-LOW</sub>) \*10<sup>6</sup> / (V<sub>R</sub> \* ΔTemperature). V<sub>OUT-HIGH</sub> is the highest voltage measured over the temperature range. V<sub>OUT-LOW</sub> is the lowest voltage measured over the temperature range.
  - 4: Load regulation is measured at a constant junction temperature using low duty-cycle pulse testing. Load regulation is tested over a load range from 1 mA to the maximum specified output current.
  - 5: Dropout voltage is defined as the input-to-output voltage differential at which the output voltage drops 2% below its nominal value that was measured with an input voltage of V<sub>IN</sub> = V<sub>OUTMAX</sub> + V<sub>DROPOUT(MAX)</sub>.
  - 6: The maximum allowable power dissipation is a function of ambient temperature, the maximum allowable junction temperature and the thermal resistance from junction to air. (i.e., T<sub>A</sub>, T<sub>J</sub>, θ<sub>JA</sub>). Exceeding the maximum allowable power dissipation will cause the device operating junction temperature to exceed the maximum +150°C rating. Sustained junction temperatures above 150°C can impact device reliability.
  - 7: The junction temperature is approximated by soaking the device under test at an ambient temperature equal to the desired junction temperature. The test time is small enough such that the rise in the junction temperature over the ambient temperature is not significant.

## AC/DC CHARACTERISTICS (CONTINUED)

**Electrical Specifications:** Unless otherwise noted,  $V_{IN} = V_{OUT(MAX)} + V_{DROPOUT(MAX)}$  **Note 1**,  $V_R$ =1.8V for Adjustable Output,  $I_{OUT}$  = 1 mA,  $C_{IN}$  =  $C_{OUT}$  = 4.7  $\mu$ F (X7R Ceramic),  $T_A$  = +25°C. **Boldface** type applies for junction temperatures,  $T_J$  (**Note 7**) of -40°C to +125°C

Parameters	Sym	Min	Тур	Max	Units	Conditions		
Voltage Regulation	V <sub>OUT</sub>	V <sub>R</sub> - 2.5%	V <sub>R</sub> ±0.5%	V <sub>R</sub> + 2.5%	V	Note 2		
Dropout Characteristics								
Dropout Voltage	V <sub>IN</sub> -V <sub>OUT</sub>		330	600	mV	Note 5, I <sub>OUT</sub> = 1.5A, V <sub>IN(MIN)</sub> = 2.3V		
Power Good Characteristics								
PWRGD Input Voltage Operat-	V <sub>PWRGD_VIN</sub>	1.0		6.0	<b>V</b>	T <sub>A</sub> = +25°C		
ing Range		1.2	_	6.0		$T_A = -40^{\circ}C \text{ to } +125^{\circ}C$		
						For $V_{IN}$ < 2.3V, $I_{SINK}$ = 100 $\mu$ A		
PWRGD Threshold Voltage	$V_{PWRGD\_TH}$				%V <sub>OUT</sub>	Falling Edge		
(Referenced to V <sub>OUT</sub> )		89	92	95		V <sub>OUT</sub> < 2.5V Fixed, V <sub>OUT</sub> = Adj.		
		90	92	94		V <sub>OUT</sub> >= 2.5V Fixed		
PWRGD Threshold Hysteresis	$V_{PWRGD\_HYS}$	1.0	2.0	3.0	%V <sub>OUT</sub>			
PWRGD Output Voltage Low	$V_{PWRGD\_L}$	_	0.2	0.4	<b>V</b>	I <sub>PWRGD SINK</sub> = 1.2 mA, ADJ = 0V		
PWRGD Leakage	P <sub>WRGD_LK</sub>	_	1	_	nA	$V_{PWRGD} = V_{IN} = 6.0V$		
PWRGD Time Delay	T <sub>PG</sub>	_	200		μs	Rising Edge $R_{PULLUP} = 10 \text{ k}\Omega$		
Detect Threshold to PWRGD Active Time Delay	T <sub>VDET-PWRGD</sub>		200	_	μs	$V_{ADJ}$ or $V_{OUT} = V_{PWRGD\_TH} + 20 \text{ mV to } V_{PWRGD\_TH} - 20 \text{ mV}$		
Shutdown Input								
Logic High Input	V <sub>SHDN-HIGH</sub>	45			%V <sub>IN</sub>	V <sub>IN</sub> = 2.3V to 6.0V		
Logic Low Input	V <sub>SHDN-LOW</sub>			15	$%V_{IN}$	V <sub>IN</sub> = 2.3V to 6.0V		
SHDN Input Leakage Current	SHDN <sub>ILK</sub>	-0.1	±0.001	+0.1	μΑ	$\frac{V_{IN}}{SHDN} = 6V, \overline{SHDN} = V_{IN}, \overline{SHDN} = GND$		
AC Performance								
Output Delay From SHDN	T <sub>OR</sub>		100		μs	$\overline{\text{SHDN}}$ = GND to V <sub>IN</sub> V <sub>OUT</sub> = GND to 95% V <sub>R</sub>		
Output Noise	e <sub>N</sub>	_	2.0	_	μV/√Hz	$I_{OUT}$ = 200 mA, f = 1 kHz, $C_{OUT}$ = 10 $\mu$ F (X7R Ceramic), $V_{OUT}$ = 2.5V		

- Note 1: The minimum  $V_{IN}$  must meet two conditions:  $V_{IN} \ge 2.3V$  and  $V_{IN} \ge V_{OUT(MAX)} + V_{DROPOUT(MAX)}$ .
  - 2:  $V_R$  is the nominal regulator output voltage for the fixed cases.  $V_R$  = 1.2V, 1.8V, etc.  $V_R$  is the desired set point output voltage for the adjustable cases.  $V_R$  =  $V_{ADJ}$  \* (( $R_1/R_2$ )+1). Figure 4-1.
  - 3: TCV<sub>OUT</sub> = (V<sub>OUT-HIGH</sub> V<sub>OUT-LOW</sub>) \*10<sup>6</sup> / (V<sub>R</sub> \* ΔTemperature). V<sub>OUT-HIGH</sub> is the highest voltage measured over the temperature range. V<sub>OUT-LOW</sub> is the lowest voltage measured over the temperature range.
  - 4: Load regulation is measured at a constant junction temperature using low duty-cycle pulse testing. Load regulation is tested over a load range from 1 mA to the maximum specified output current.
  - 5: Dropout voltage is defined as the input-to-output voltage differential at which the output voltage drops 2% below its nominal value that was measured with an input voltage of V<sub>IN</sub> = V<sub>OUTMAX</sub> + V<sub>DROPOUT(MAX)</sub>.
  - 6: The maximum allowable power dissipation is a function of ambient temperature, the maximum allowable junction temperature and the thermal resistance from junction to air. (i.e., T<sub>A</sub>, T<sub>J</sub>, θ<sub>JA</sub>). Exceeding the maximum allowable power dissipation will cause the device operating junction temperature to exceed the maximum +150°C rating. Sustained junction temperatures above 150°C can impact device reliability.
  - 7: The junction temperature is approximated by soaking the device under test at an ambient temperature equal to the desired junction temperature. The test time is small enough such that the rise in the junction temperature over the ambient temperature is not significant.

## MCP1827/MCP1827S

## AC/DC CHARACTERISTICS (CONTINUED)

**Electrical Specifications:** Unless otherwise noted,  $V_{IN} = V_{OUT(MAX)} + V_{DROPOUT(MAX)}$  **Note 1**,  $V_R$ =1.8V for Adjustable Output,  $I_{OUT} = 1$  mA,  $C_{IN} = C_{OUT} = 4.7$  µF (X7R Ceramic),  $T_A = +25$ °C. **Boldface** type applies for junction temperatures,  $T_J$  (**Note 7**) of -40°C to +125°C

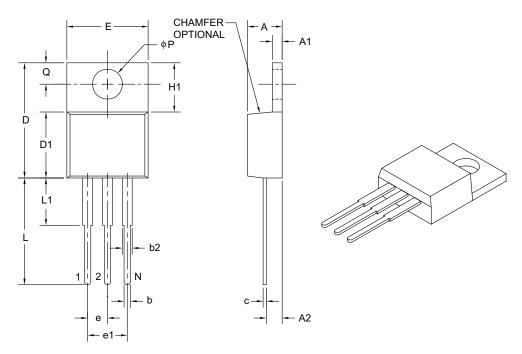
Parameters	Sym	Min	Тур	Max	Units	Conditions
Power Supply Ripple Rejection Ratio	PSRR	_	60	ı	dB	$\begin{split} f &= 100 \text{ Hz, } C_{OUT} = 10  \mu\text{F,} \\ I_{OUT} &= 10 \text{ mA,} \\ V_{INAC} &= 30 \text{ mV pk-pk,} \\ C_{IN} &= 0  \mu\text{F} \end{split}$
Thermal Shutdown Temperature	T <sub>SD</sub>	_	150		°C	I <sub>OUT</sub> = 100 μA, V <sub>OUT</sub> = 1.8V, V <sub>IN</sub> = 2.8V
Thermal Shutdown Hysteresis	$\DeltaT_SD$	_	10	_	°C	I <sub>OUT</sub> = 100 μA, V <sub>OUT</sub> = 1.8V, V <sub>IN</sub> = 2.8V

- The minimum  $V_{IN}$  must meet two conditions:  $V_{IN} \ge 2.3V$  and  $V_{IN} \ge V_{OUT(MAX)} + V_{DROPOUT(MAX)}$ . Note 1:
  - $V_R$  is the nominal regulator output voltage for the fixed cases.  $V_R = 1.2V$ , 1.8V, etc.  $V_R$  is the desired set point output voltage for the adjustable cases.  $V_R = V_{ADJ} * ((R_1/R_2) + 1)$ . Figure 4-1.  $TCV_{OUT} = (V_{OUT-HIGH} V_{OUT-LOW}) *10^6 / (V_R * \Delta Temperature). V_{OUT-HIGH} is the highest voltage measured over the$
  - temperature range. V<sub>OUT-LOW</sub> is the lowest voltage measured over the temperature range.
  - Load regulation is measured at a constant junction temperature using low duty-cycle pulse testing. Load regulation is tested over a load range from 1 mA to the maximum specified output current.
  - Dropout voltage is defined as the input-to-output voltage differential at which the output voltage drops 2% below its nominal value that was measured with an input voltage of V<sub>IN</sub> = V<sub>OUTMAX</sub> + V<sub>DROPOUT(MAX)</sub>.
  - 6: The maximum allowable power dissipation is a function of ambient temperature, the maximum allowable junction temperature and the thermal resistance from junction to air. (i.e.,  $T_A$ ,  $T_J$ ,  $\theta_{JA}$ ). Exceeding the maximum allowable power dissipation will cause the device operating junction temperature to exceed the maximum +150°C rating. Sustained junction temperatures above 150°C can impact device reliability.
  - 7: The junction temperature is approximated by soaking the device under test at an ambient temperature equal to the desired junction temperature. The test time is small enough such that the rise in the junction temperature over the ambient temperature is not significant.

#### TEMPERATURE SPECIFICATIONS

Electrical Specifications: Unless otherwise indicated, all limits apply for V <sub>IN</sub> = 2.3V to 6.0V.							
Parameters	Sym	Min	Тур	Max	Units	Conditions	
Temperature Ranges							
Operating Junction Temperature Range	T <sub>J</sub>	-40	_	+125	°C	Steady State	
Maximum Junction Temperature	T <sub>J</sub>	_	_	+150	°C	Transient	
Storage Temperature Range	T <sub>A</sub>	-65	_	+150	°C		
Thermal Package Resistances							
Thermal Resistance, 5LD DDPAK	$\theta_{JA}$	_	31.2	_	°C/W	4-Layer JC51 Standard Board	
Thermal Resistance, 3LD DDPAK	$\theta_{JA}$	_	31.4	_	°C/W	4-Layer JC51 Standard Board	
Thermal Resistance, 5LD TO-220	$\theta_{JA}$	_	29.3	_	°C/W	4-Layer JC51 Standard Board	
Thermal Resistance, 3LD TO-220	$\theta_{JA}$	_	29.4	_	°C/W	4-Layer JC51 Standard Board	

## 3-Lead Plastic Transistor Outline (AB) [TO-220]



	Units			INCHES			
	Dimension Limits	MIN	NOM	MAX			
Number of Pins	N		3				
Pitch	е	.100 BSC					
Overall Pin Pitch	e1	.200 BSC					
Overall Height	A	.140	_	.190			
Tab Thickness	A1	.020	_	.055			
Base to Lead	A2	.080	_	.115			
Overall Width	Е	.357	_	.420			
Mounting Hole Center	Q	.100	_	.120			
Overall Length	D	.560	_	.650			
Molded Package Length	D1	.330	_	.355			
Tab Length	H1	.230	_	.270			
Mounting Hole Diameter	φР	.139	_	.156			
Lead Length	L	.500	_	.580			
Lead Shoulder	L1	_	_	.250			
Lead Thickness	С	.012	_	.024			
Lead Width	b	.015	.027	.040			
Shoulder Width	b2	.045	.057	.070			

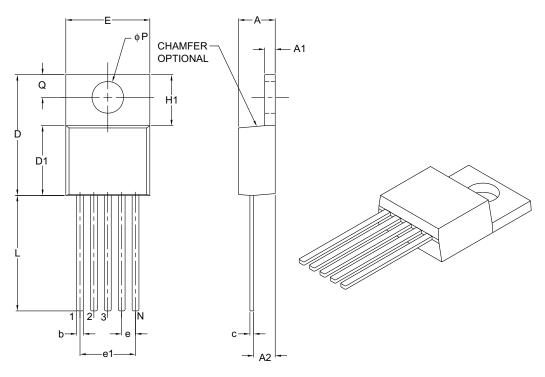
#### Notes:

- 1. Dimensions D and E do not include mold flash or protrusions. Mold flash or protrusions shall not exceed .005" per side.
- 2. Dimensioning and tolerancing per ASME Y14.5M.

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing C04-034B

## 5-Lead Plastic Transistor Outline (AT) [TO-220]



	Units		INCHES		
	Dimension Limits	MIN	NOM	MAX	
Number of Pins	N	5			
Pitch	е	.067 BSC			
Overall Pin Pitch	e1	.268 BSC			
Overall Height	A	.140	_	.190	
Overall Width	E	.380	-	.420	
Overall Length	D	.560	_	.650	
Molded Package Length	D1	.330	_	.355	
Tab Length	H1	.204	-	.293	
Tab Thickness	A1	.020	-	.055	
Mounting Hole Center	Q	.100	_	.120	
Mounting Hole Diameter	φР	.139	_	.156	
Lead Length	L	.482	_	.590	
Base to Bottom of Lead	A2	.080	-	.115	
Lead Thickness	С	.012	_	.025	
Lead Width	b	.015	.027	.040	

#### Notes:

- 1. Dimensions D and E do not include mold flash or protrusions. Mold flash or protrusions shall not exceed .005" per side.
- 2. Dimensioning and tolerancing per ASME Y14.5M.

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing C04-036B

## PRODUCT IDENTIFICATION SYSTEM

To order or obtain information, e.g., on pricing or delivery, refer to the factory or the listed sales office.

PART NO. XX	<u>x x x/ xx</u>	Examples:
 Device Output Voltage	Feature Tolerance Temp. Package	a) MCP1827-0802E/AT: 0.8V LDO Regulator 5LD TO-220
voitage	Code	b) MCP1827-1002E/ET: 1.0V LDO Regulator 5LD DDPAK
Device:	MCP1827: 1.5A Low Dropout Regulator MCP1827T: 1.5A Low Dropout Regulator Tape and Reel MCP1827S: 1.5A Low Dropout Regulator MCP1827ST: 1.5A Low Dropout Regulator Tape and Reel	c) MCP1827-1202E/AT: 1.2V LDO Regulator 5LD TO-220
		d) MCP1827-1802E/AT: 1.8V LDO Regulator 5LD TO-220
		e) MCP1827-2502E/ET: 2.5V LDO Regulator 5LD DDPAK
Output Voltage *:	08 = 0.8V "Standard"	f) MCP1827-3002E/ET: 3.0V LDO Regulator 5LD DDPAK
	12 = 1.2V "Standard" 18 = 1.8V "Standard" 25 = 2.5V "Standard"	g) MCP1827-3302E/AT 3.3V LDO Regulator 5LD TO-220
	30 = 3.0V "Standard" 33 = 3.3V "Standard"	h) MCP1827-5002E/ET: 5.0V LDO Regulator 5LD DDPAK
	50 = 5.0V "Standard"  *Contact factory for other output voltage options	i) MCP1827-ADJE/AT: ADJ LDO Regulator 5LD TO-220
Extra Feature Code:	0 = Fixed	a) MCP1827S-0802E/EB:0.8V LDO Regulator
Tolerance:	2 = 2.0% (Standard)	3LD DDPAK b) MCP1827S-0802E/AB:0.8V LDO Regulator 3LD TO-220
Temperature:	E = -40°C to +125°C	c) MCP1827S-1002E/EB:1.0V LDO Regulator 3LD DDPAK
Package Type:	AB = Plastic Transistor Outline, TO-220, 3-lead AT = Plastic Transistor Outline, TO-220, 5-lead	d) MCP1827S-1202E/AB 1.2V LDO Regulator 3LD TO-220
	EB = Plastic, DDPAK, 3-lead ET = Plastic, DDPAK, 5-lead	e) MCP1827S-1802E/EB 1.8V LDO Regulator 3LD DDPAK
		f) MCP1827S-2502E/EB 2.5V LDO Regulator 3LD DDPAK
		g) MCP1827S-2502E/EB 3.0V LDO Regulator 3LD DDPAK
		h) MCP1827S-3302E/AB 3.3V LDO Regulator 3LD TO-220
		i) MCP1827S-5002E/EB 5.0V LDO Regulator 3LD DDPAK
		j) MCP1827S-ADJE/AB ADJ LDO Regulator 3LD TO-220